Product Preview

N-Channel Power MOSFET 600 V, 360 m Ω

Features

- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

ABSOLUTE MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	NDF	NDD	Unit
Drain-to-Source Voltage			V _{DSS}	600		V
Gate-to-Source Voltage			V _{GS}	±25		V
Continuous Steady Drain State Current		T _C = 25°C	Ι _D	13	11	Α
R _{θJC} (Note 1)		T _C = 100°C		8.1	7.3	
Power Dissipation – R ₀ JC	Steady State	T _C = 25°C	P_{D}	30	114	W
Pulsed Drain Current	t _p =	10 μs	I _{DM}	51	46	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to	+150	°C
Source Current (Body Diode)			I _S	13	11	Α
Single Pulse Drain-to-Source Avalanche Energy			EAS	TBD		mJ
Lead Temperature for Soldering Leads			T _L	26	50	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Limited by maximum junction temperature

THERMAL RESISTANCE

Parameter	Symbol	Value	Unit	
Junction-to-Case (Drain)	NDF60N360U1 NDD60N360U1	$R_{\theta JC}$	4.1 1.1	°C/W
Junction-to-Ambient Steady State NDF60N360U1 NDD60N360U1 NDD60N360U1-1		$R_{ hetaJA}$	50 31 96	°C/W

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

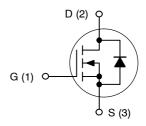


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V _{(BR)DSS}	R _{DS(ON)} MAX		
600 V	360 m Ω @ 10 V		

N-Channel MOSFET







IPAK CASE 369D



CASE 369AA

MARKING AND ORDERING INFORMATION

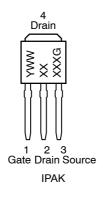
See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

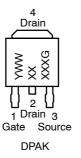
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

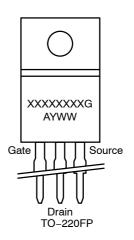
Characteristic	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA		600			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				TBD		mV/°C
Drain-to-Source Leakage Current	I _{DSS}	V _{DS} = 600 V, V _{GS} = 0 V	T _J = 25°C			1	μΑ
			T _J = 125°C			50	1
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} = ±20 V	•			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{DS} = V_{GS}, I_{D} = 50$	μΑ	2	TBD	4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	Reference to 25°C, I _D =	= 50 μΑ		TBD		mV/°C
Static Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 6.	5 A		280	360	mΩ
Forward Transconductance	9 _{FS}	$V_{DS} = 15 \text{ V}, I_D = 6.8$	5 A		TBD		S
DYNAMIC CHARACTERISTICS							
Input Capacitance	C _{iss}	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz			800		pF
Output Capacitance	C _{oss}				55		
Reverse Transfer Capacitance	C _{rss}				3.5		
Total Gate Charge	Q_{g}	V _{DS} = 300 V, I _D = 13 A, V _{GS} = 10 V			29		nC
Gate-to-Source Charge	Q_{gs}				TBD		
Gate-to-Drain Charge	Q_{gd}				TBD		
Plateau Voltage	V_{GP}		•		TBD		V
Gate Resistance	R_{g}				TBD		Ω
RESISTIVE SWITCHING CHARACTER	ISTICS (Note 3)					
Turn-on Delay Time	t _{d(on)}				TBD		ns
Rise Time	t _r	$V_{DD} = 300 \text{ V}, I_D = 100 \text{ V}$	3 A,		TBD		
Turn-off Delay Time	t _{d(off)}	$V_{GS} = 10 \text{ V}, R_{G} = 0$	Ω		TBD		1
Fall Time	t _f				TBD		1
SOURCE-DRAIN DIODE CHARACTER	RISTICS						
Diode Forward Voltage	V_{SD}	1 10 4 1/ 0 1/	$T_J = 25^{\circ}C$		TBD	1.6	V
		$I_S = 13 \text{ A}, V_{GS} = 0 \text{ V}$ $T_J = 100^{\circ}\text{C}$			TBD		1
Reverse Recovery Time	t _{rr}	$V_{GS} = 0 \text{ V}, V_{DD} = 30 \text{ V}$ $I_{S} = 13 \text{ A}, d_{i}/d_{t} = 100 \text{ A}/\mu\text{s}$			TBD		ns
Charge Time	t _a				TBD		1
Discharge Time	t _b				TBD		1
Reverse Recovery Charge	Q _{rr}				TBD		nC

Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

MARKING DIAGRAMS







A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

ORDERING INFORMATION

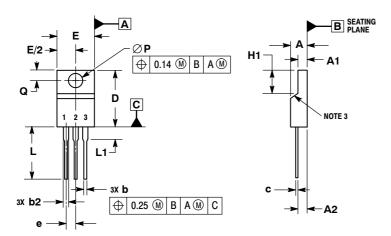
Device	Package	Shipping [†]
NDF60N360U1G	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail
NDD60N360U1-1G	IPAK (Pb-Free, Halogen-Free)	75 Units / Rail
NDD60N360U1T4G	DPAK (Pb-Free, Halogen-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

TO-220 FULLPACK, 3-LEAD

CASE 221AH ISSUE C



- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: MILLIMETERS.

 3. CONTOUR UNCONTROLLED IN THIS AREA.

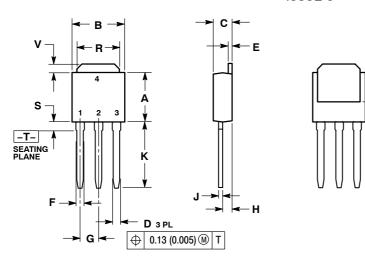
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH AND GATE PROTRUSIONS. MOLD FLASH AND GATE PROTRUSIONS NOT TO EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE TO BE MEASURED AT OUTERMOST EXTREME OF THE PLASTIC BODY.

 5. DIMENSION b2 DOES NOT INCLUDE DAMBAR PROTRUSION. LEAD WIDTH INCLUDING PROTRUSION SHALL NOT EXCEED 2.00.

	MILLIMETERS			
DIM	MIN	MAX		
Α	4.30	4.70		
A1	2.50	2.90		
A2	2.50	2.70		
b	0.54	0.84		
b2	1.10	1.40		
С	0.49	0.79		
D	14.70	15.30		
E	9.70	10.30		
е	2.54	BSC		
H1	6.70	7.10		
L	12.70	14.73		
L1		2.80		
P	3.00	3.40		
Q	2.80	3.20		

PACKAGE DIMENSIONS

IPAK CASE 369D-01 ISSUE C



Z

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

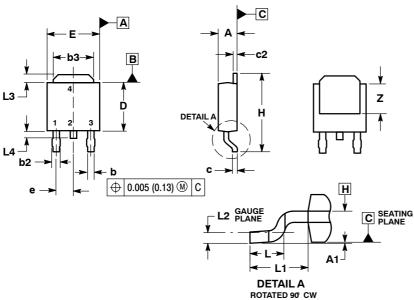
	INCHES		MILLIM	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	BSC	2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

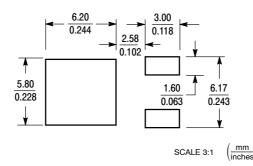
PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE)

CASE 369AA-01 **ISSUE B**



SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	0.108 REF 2.74 R		REF
L2	0.020 BSC		0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
7	0.155		3.93	

STYLE 2:

PIN 1. GATE

2. DRAIN 3. SOURCE

4. DRAIN

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